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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/822,720	04/13/2004	Masahiko Okunuki	0862.023536	3027
5514	7590	09/12/2006	EXAMINER	
FITZPATRICK CELLA HARPER & SCINTO			BERMAN, JACK I	
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NEW YORK, NY 10112			ART UNIT	PAPER NUMBER
			2881	

DATE MAILED: 09/12/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

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Office Action Summary	Application No. 10/822,720	Applicant(s) OKUNUKI ET AL.	
	Examiner Jack I. Berman	Art Unit 2881	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 30 June 2006.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-12 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-12 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 13 April 2004 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☒ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☒ All b) ☐ Some * c) ☐ None of:
1. ☒ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|--|---|
| 1) <input type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08)
Paper No(s)/Mail Date _____ | 6) <input type="checkbox"/> Other: _____ |

Claim 1 is objected to because of the following informalities: In line 6, the newly inserted language refers to a "bias position", but the context clearly indicates that the language is intended to refer to the --bias portion-- cited two lines above. Appropriate correction is required.

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 1, 3, 4, and 10-12 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ooah et al. in view of Beisswenger et al. Ooah et al. discloses an electron beam exposure apparatus comprising: an electron gun (114) including a cathode portion (111) which emits electrons, an anode portion (113, 41) which accelerates the emission of electrons, a bias portion (grid or Wehnelt electrode 112 in Fig. 2 or control electrode 49 and lens electrode 42 in Fig. 7, which together act as a Wehnelt electrode as is explained at lines 65-66 in column 12) which is arranged between said cathode portion and anode portion and controls the trajectories of the emitted electrons so as to form a crossover (CO in Figure 7) between the bias portion and the

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anode portion, a shielding portion (beam-cutting-off aperture 411) which is arranged below said anode portion and shields some of the emission electrons, and a cooling portion (430 in Figure 17) which cools said shielding portion; and a stage (135) which moves in holding a substrate to be exposed by using the emission electrons. Ooaeh et al. also inherently teaches to use this apparatus to expose a substrate for subsequent development. Furthermore, as was also explained in the previous Office action, Figure 17 of Ooaeh et al. suggests that the shielding portion (411) and the cooling portion (430) are separable, and at lines 56-59 in column 17 Ooaeh et al. teaches that the shielding portion should be made of Mo (molybdenum), one of the high-melting materials defined at lines 26-27 on page 12 of the specification instant application as being appropriate for use as the material of the shielding portion. Ooaeh et al. does not, however, explain how the shielding portion is joined to the cooling portion. The interposition of a low-melting material between two high-melting materials is a well-known method of connecting metal components, as can be seen in the article on soldering from Encyclopedia Britannica. It would therefore have been obvious to a person having ordinary skill in the art to use this well-known method to join Ooaeh et al.'s shielding and cooling portions. On the other hand, it would have been obvious to a person having ordinary skill in the art to make the shielding portion and the cooling portion integral because making two objects integral instead of separable is long established in patent law as being obvious. It is noted that Ooaeh et al.'s anode (41) has an aperture (A1), as is clearly illustrated in Figure 7. Ooaeh et al. does not go into any great detail about the structure of the shielding portion (411) or teach about detecting electrons becoming incident on the shielding portion and using this detection result to control an application voltage, but Beisswenger et al. teaches that by forming such a shielding portion (restrictor M) with a tilt

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portion tilting with respect to an incident direction of the incident emission electrons and a closing portion (not labeled but clearly shown in Fig. 1 as an apertured portion near the auxiliary electrode (W)) that inhibits electrons reflected by the tilt portion from passing through the aperture of the anode portion located between the tilt portion and the anode portion, when the shielding portion (M) is disposed in front of the anode as is taught at lines 21-24 in column 2 of the patent, a portion (Faraday cage FK) of the shielding portion (M) acts as a detecting portion which detects the electrons becoming incident on said shielding portion, and a control portion (the control circuit illustrated in Figure 2 of Beisswenger et al.) which controls an application voltage on the basis of a detection result of said detecting portion can be provided to keep the electron beam emitted by the beam generator highly steady. It would have been obvious to a person having ordinary skill in the art to form Ooaeh et al.'s shielding portion in the shape disclosed by Beisswenger et al. in order to make use of the control circuit taught by Beisswenger et al. to keep the electron beam emitted highly steady in the manner taught by Beisswenger et al.

Claim 2 is rejected under 35 U.S.C. 103(a) as being unpatentable over Ooaeh et al. and Beisswenger et al. as applied to claims 1, 3, 4, and 10-12 above, and further in view of Takigawa. While Ooaeh et al. does describe some embodiments of the invention that use a cathode formed with a flat surface (see for example Figures 7 and 8A), the embodiment that uses the shielding (or beam-cutting-off aperture 411) does not place any restrictions on the shape of the cathode used in the apparatus. Takigawa et al., on the other hand, teaches that an electron beam with a highly controllable diameter at a beam crossover point can be formed using a cathode (emitter) having a hemispherical (i.e. rounded) top surface. See lines 24-32 in column 3. It would have been obvious to a person having ordinary skill in the art to use Takigawa's cathode

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having a hemispherical top surface as the cathode in the Ooaeh et al./Beisswenger et al. apparatus discussed above in order to achieve the controllable beam diameter taught by Takigawa.

Claims 5 and 6 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ooaeh et al. and Beisswenger et al. as applied to claims 1, 3, 4, and 10-12 above, and further in view of Leung et al. At lines 40-53 in column 12, Leung et al. teaches that when a cooling portion is used with a Faraday cage (210) to measure the current of an electron beam, it must include an insulator and deionized water (another term for the “insulating pure water” defined at lines 5-6 on page 14 of the specification of the instant specification as one of two possible cooling media that serve as the antecedent basis for the “cooling medium having a predetermined resistance” in claim 5) should be passed through the cooling portion. It would have been obvious to a person having ordinary skill in the art to apply Leung et al.’s teachings on how to cool Faraday cages when Beisswenger et al.’s combination shielding portion and Faraday cage was used as the shielding portion to be cooled in the Ooaeh et al. apparatus.

Claims 7-9 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ooaeh et al. and Beisswenger et al. as applied to claims 1, 3, 4, and 10-12 above, and further in view of Hamaguchi et al. While Ooaeh et al. discloses only a single electron gun, Hamaguchi et al. teaches that a plurality of electron guns (10) can be provided in a single chamber and that additional electrodes (slit-deflecting unit 15) to which voltages are applied can be provided between the anode (13) and the shielding portions (slit covers 11). It would have been obvious to a person having ordinary skill in the art to provide a plurality of Ooaeh et al.’s electron guns in a single chamber and to provide the additional electrodes taught by Hamaguchi et al. in order to

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produce more semiconductor devices more rapidly in the manner discussed by Hamaguchi et al. at paragraph [0006]. Since Hamaguchi et al. teaches to control each of the electron guns individually by means of individual controller (120), it would have been obvious to a person having ordinary skill in the art to use a plurality of Beisswenger et al. shielding portions with their related detecting and controlling portions to control each of the Ooaeh et al. electron guns independently of each other and thereby keep each of them steady.

Applicant's arguments filed June 30, 2006 have been fully considered but they are not persuasive because they are based on mistaken interpretations of the references. On page 9 of the arguments, applicant states: "A guide electrode 48 of an electron gun 10, as shown in Figure 7, may be considered to correspond to the shielding portion of the present invention." Such a correspondence was never asserted by the examiner. Instead, the examiner has clearly stated above and in previous Office actions that it is element 411 of the Ooaeh et al. patent, referred to in the patent as a "beam-cutting-off aperture", that corresponds to the "shielding portion" of the instant invention and that it is this portion that is cooled by a cooling mechanism 430. Similarly, applicant further argues, on the same page of the arguments: "The anode electrode may be considered to correspond to the shielding portion of the present invention." Again, the examiner has clearly stated above and in previous Office actions that Beisswenger et al. teaches at lines 21-24 in column 2 (the examiner mistakenly typed "column 3" in the previous Office, for which he apologizes, but this doesn't affect the substance of the contents of the Beisswenger et al. patent, especially since Beisswenger et al. contains less than three columns of specification) that while the shielding portion may be used as the anode, it may also be provided after the anode. Since applicant's arguments are based on incorrect premises, they are not persuasive.

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THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

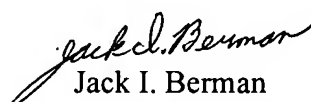
A shortened statutory period for reply to this final action is set to expire **THREE MONTHS** from the mailing date of this action. In the event a first reply is filed within **TWO MONTHS** of the mailing date of this final action and the advisory action is not mailed until after the end of the **THREE-MONTH** shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than **SIX MONTHS** from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jack I. Berman whose telephone number is (571) 272-2468. The examiner can normally be reached on Monday-Thursday (8:30-7:00).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John R. Lee can be reached on (571) 272-2477. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.


Jack I. Berman
Primary Examiner
Art Unit 2881

jb
9/5/06